



#### **General Description**

The WSM320N04G is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications . The WSM320N04G meet the RoHS and Green Product requirement , 100% EAS guaranteed with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

#### **Product Summery**

| BVDSS | RDSON | ID   |
|-------|-------|------|
| 40V   | 1.2mΩ | 320A |

#### **Applications**

- High Frequency Point-of-Load Synchronous Buck Converter
- Networking DC-DC Power System
- Power Tool Application

#### **TOLLA-8L Pin Configuration**



#### **Absolute Maximum Ratings**

| Symbol                               | Parameter  | Rating     | Units      |
|--------------------------------------|--|------------|------------|
| $V_{DS}$                             | Drain-Source Voltage   | 40         | V          |
| $V_{GS}$                             | Gate-Source Voltage  | ±20        | V          |
| I <sub>D</sub> @T <sub>C</sub> =25℃  | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,7</sup> | 320        | Α          |
| I <sub>D</sub> @T <sub>C</sub> =100℃ | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,7</sup> | 192        | А          |
| I <sub>DM</sub>                      | Pulsed Drain Current <sup>2</sup>                              | 900        | А          |
| EAS                                  | Single Pulse Avalanche Energy <sup>3</sup>                     | 980        | mJ         |
| I <sub>AS</sub>                      | Avalanche Current  | 70         | Α          |
| P <sub>D</sub> @T <sub>C</sub> =25°C | Total Power Dissipation⁴                                       | 250        | W          |
| T <sub>STG</sub>                     | Storage Temperature Range                                      | -55 to 175 | °C         |
| TJ                                   | Operating Junction Temperature Range                           | -55 to 175 | $^{\circ}$ |

#### **Thermal Data**

| Symbol         | Parameter  |  | Max. | Unit |
|----------------|--|--|------|------|
| $R_{	heta JA}$ | Thermal Resistance Junction-Ambient <sup>1</sup> |  | 55   | °C/W |
| $R_{	heta JC}$ | Thermal Resistance Junction-Case <sup>1</sup>    |  | 0.6  | °C/W |



### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

| Symbol                               | Parameter                                      | Conditions  | Min. | Тур.  | Max. | Unit |
|--------------------------------------|--|---|------|-------|------|------|
| BV <sub>DSS</sub>                    | Drain-Source Breakdown Voltage                 | $V_{GS}$ =0 $V$ , $I_D$ =250 $u$ A                                | 40   |       |      | V    |
| $\triangle BV_{DSS}/\triangle T_{J}$ | BV <sub>DSS</sub> Temperature Coefficient      | Reference to 25℃ , I <sub>D</sub> =1mA                            |      | 0.050 |      | V/°C |
| R <sub>DS(ON)</sub>                  | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =10V , I <sub>D</sub> =25A                        |      | 1.2   | 1.5  | mΩ   |
| R <sub>DS(ON)</sub>                  | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}$ =4.5V , $I_D$ =20A                                       |      | 1.7   | 2.5  | mΩ   |
| $V_{GS(th)}$                         | Gate Threshold Voltage                         | -V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA         | 1.2  | 1.7   | 2.6  | V    |
| $\triangle V_{GS(th)}$               | V <sub>GS(th)</sub> Temperature Coefficient    | V <sub>GS</sub> -V <sub>DS</sub> , I <sub>D</sub> -250uA          |      | -6.94 |      | mV/℃ |
| l                                    | Drain Source Leakage Current                   | V <sub>DS</sub> =40V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C |      |       | 1    |      |
| I <sub>DSS</sub>                     | Drain-Source Leakage Current                   | V <sub>DS</sub> =40V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C |      |       | 10   | · uA |
| I <sub>GSS</sub>                     | Gate-Source Leakage Current                    | $V_{GS}$ = $\pm 20 V$ , $V_{DS}$ = $0 V$                          |      |       | ±100 | nA   |
| gfs                                  | Forward Transconductance                       | V <sub>DS</sub> =5V , I <sub>D</sub> =50A                         |      | 160   |      | S    |
| $R_g$                                | Gate Resistance                                | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                |      | 1.0   |      | Ω    |
| $Q_g$                                | Total Gate Charge (10V)                        |   |      | 130   |      |      |
| Q <sub>gs</sub>                      | Gate-Source Charge                             | $V_{DS}$ =20V , $V_{GS}$ =10V , $I_{D}$ =25A                      |      | 43    |      | nC   |
| $Q_{gd}$                             | Gate-Drain Charge                              |   |      | 83    |      |      |
| T <sub>d(on)</sub>                   | Turn-On Delay Time                             |   |      | 30    |      |      |
| Tr                                   | Rise Time                                      | V <sub>DD</sub> =20V , V <sub>GEN</sub> =4.5V ,                   |      | 115   |      |      |
| T <sub>d(off)</sub>                  | Turn-Off Delay Time                            | $R_G$ =2.7 $\Omega$ , $I_D$ =1A.                                  |      | 95    |      | ns   |
| T <sub>f</sub>                       | Fall Time                                      |   |      | 80    |      |      |
| C <sub>iss</sub>                     | Input Capacitance                              |   |      | 8100  |      |      |
| C <sub>oss</sub>                     | Output Capacitance                             | V <sub>DS</sub> =20V , V <sub>GS</sub> =0V , f=1MHz               |      | 1200  |      | pF   |
| C <sub>rss</sub>                     | Reverse Transfer Capacitance                   |   |      | 800   |      |      |

#### **Guaranteed Avalanche Characteristics**

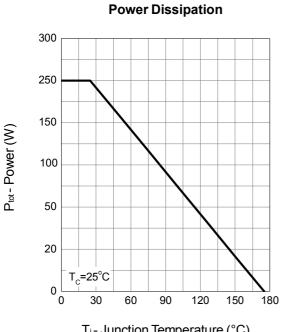
| Symbol | Parameter                                  | Conditions  | Min. | Тур. | Max. | Unit |
|--------|--|---|------|------|------|------|
| EAS    | Single Pulse Avalanche Energy <sup>5</sup> | V <sub>DD</sub> =20V , L=0.5mH , I <sub>AS</sub> =70A | 500  |      |      | mJ   |

#### **Diode Characteristics**

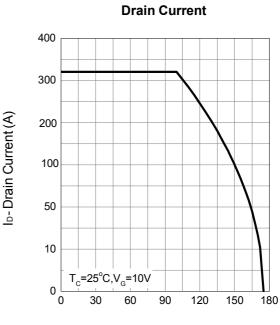
| Symbol          | Parameter                                | Conditions  | Min. | Тур. | Max. | Unit |
|-----------------|--|---|------|------|------|------|
| I <sub>S</sub>  | Continuous Source Current <sup>1,6</sup> | -V <sub>G</sub> =V <sub>D</sub> =0V , Force Current             |      |      | 320  | Α    |
| I <sub>SM</sub> | Pulsed Source Current <sup>2,6</sup>     | V <sub>G</sub> -V <sub>D</sub> -UV , Force Current              |      |      | 900  | Α    |
| V <sub>SD</sub> | Diode Forward Voltage <sup>2</sup>       | V <sub>GS</sub> =0V , I <sub>S</sub> =30A , T <sub>J</sub> =25℃ |      |      | 1.2  | V    |

- 1 .The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec . 2 .The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%
- 3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =20V, $V_{GS}$ =10V,L=0.5mH, $I_{AS}$ =70A
- 4. The power dissipation is limited by 150 ℃ junction temperature 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.
- 7. Package limitation current is 100A.



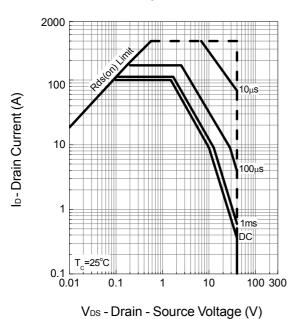


T<sub>j</sub>-Junction Temperature (°C)

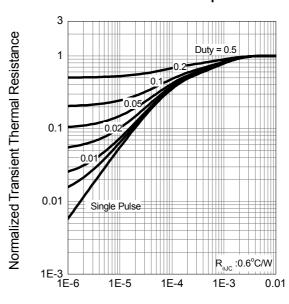


T<sub>j</sub>- Junction Temperature (°C)

#### **Safe Operation Area**



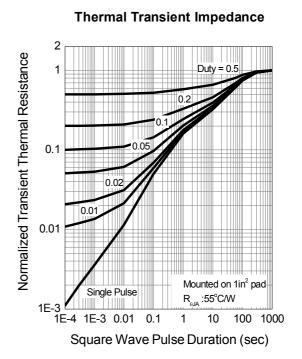
#### **Thermal Transient Impedance**

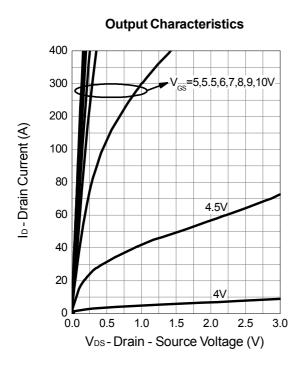


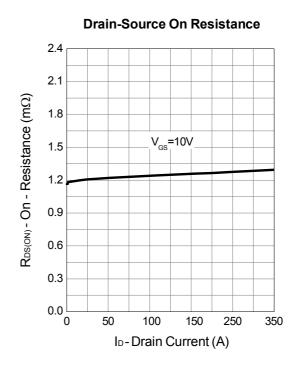
Square Wave Pulse Duration (sec)



V<sub>DS</sub> - Drain - Source Voltage (V)

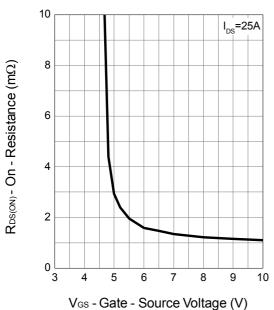




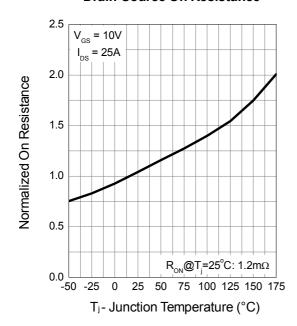




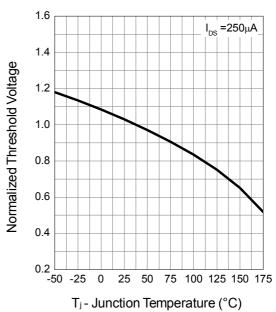
# Gate-Source On Resistance



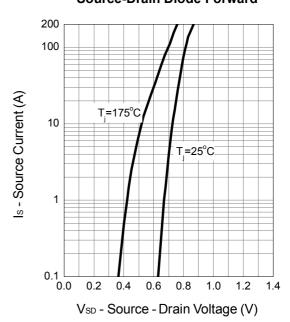
### Drain-Source On Resistance



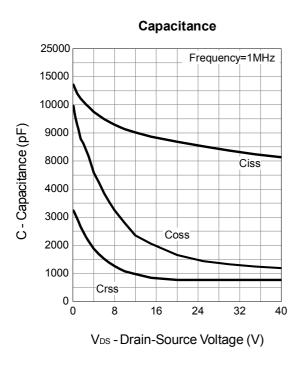
### **Gate Threshold Voltage**

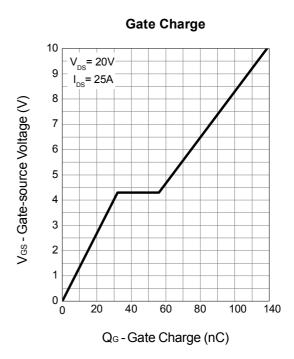


#### Source-Drain Diode Forward

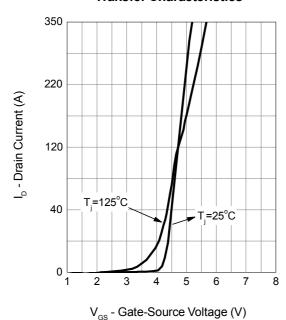






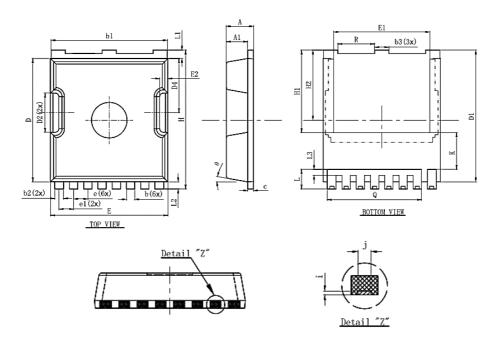


#### **Transfer Characteristics**





### **Packaging information**



| Symbol | Dimensions In Millimeters |             |      |  |  |  |
|--------|---------------------------|-------------|------|--|--|--|
| Symbol | Min.                      | Nom         | Max. |  |  |  |
| Α      | 2.2                       | 2.3         | 2.4  |  |  |  |
| A1     | 1.7                       | 1.8         | 1.9  |  |  |  |
| b      | 0.6                       | 0.7         | 0.8  |  |  |  |
| b1     | 9.7                       | 9.8         | 9.9  |  |  |  |
| b2     | 0.65                      | 0.75        | 0.85 |  |  |  |
| b3     | 1.1                       | 1.2         | 1.3  |  |  |  |
| С      | 0.4                       | 0.5         | 0.6  |  |  |  |
| D      | 10.3                      | 10.4        | 10.5 |  |  |  |
| D1     | 11.0                      | 11.1        | 11.2 |  |  |  |
| D2     | 3.2                       | 3.3         | 3.4  |  |  |  |
| D4     | 4.47                      | 4.57        | 4.67 |  |  |  |
| E      | 9.8                       | 9.9         | 10.0 |  |  |  |
| E1     | 8.0                       | 8.1         | 8.2  |  |  |  |
| E2     | 0.5                       | 0.6         | 0.7  |  |  |  |
| е      |                           | 1.200 (BSC) |      |  |  |  |
| e1     |                           | 1.225 (BSC) |      |  |  |  |
| Н      | 11.6                      | 11.7        | 11.8 |  |  |  |
| H1     |                           | 6.95BSC     |      |  |  |  |
| H2     |                           | 5.9BSC      |      |  |  |  |
| i      |                           | 0.1REF      |      |  |  |  |
| j      |                           | 0.350REF    |      |  |  |  |
| K      |                           | 3.100REF    |      |  |  |  |
| L      | 1.55                      | 1.65        | 1.75 |  |  |  |
| L1     | 0.6                       | 0.7         | 0.8  |  |  |  |
| L2     | 0.5                       | 0.6         | 0.7  |  |  |  |
| L3     | 0.4                       | 0.5         | 0.6  |  |  |  |
| Q      |                           | 7.95REF     |      |  |  |  |
| R      | 3.0                       | 3.1         | 3.2  |  |  |  |
| θ      | 10°REG                    |             |      |  |  |  |



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